Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/685,002	KIM ET AL.
Examiner	**Art Unit**
Dennis Rosario	2624

SEARCHED			
Class	Subclass	Date	Examiner
382	118, 190 191, 195	11/29/07	DR
	201, 205		
	206, 225		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See PG Pub		1/26/07	DR
Printout			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East, all dB	11/29/07	DR
Inventor	1/26/07	DR
PG Pub Printout	1/26/07	DR
IEEE - Feature (near) vector and Fourier and image -	1/26/07	DR